NSN 5910-01-396-1079

Test Data Document:

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Body Style:
Chip type
Reliability Indicator:
Established
Reliability Failure Rate Level In Percent:
1.000
Terminal Length:
0.5 millimeters
Body Length:
3.2 millimeters
Body Width:
1.6 millimeters
Body Height:
1.3 millimeters
Schematic Diagram Designator:
No common or grounded electrode (s)
End Application:
5820-01-365-2725 receiver-transmitter, radio
Insulation Resistance At Maximum Operating Temp:
1000.0 megohms
Capacitance Value Per Section:
2.000 picofarads single section
Nonderated Operating Temp:
Between -55.0 degrees celsius and 125.0 degrees celsius
Tempurature Coefficient Of Capacitance Per Section In Ppm Per Deg Celsius:
0.0 single section
Nonderated Continuous Voltage Rating And Type Per Section:
100.0 dc single section
Tolerance Of Tempurature Coefficient Per Section In Ppm Per Deg Celsius:
-30.0/+30.0 single section
Tolerance Range Per Section:
-0.25/+0.25 picofarads single section
Case Material:
Ceramic
Insulation Resistance At Reference Temp:
100000.0 megohms
Dissipation Factor At Reference Tempurature In Percent:
2.500
Terminal Surface Treatment:
Solder

81349-mil-c-55681 specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification format; excludes commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain environmental and performance requirements and test conditions that are shown as "typical", "average", "", etc.).

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Terminal Type And Quantity:
2 bonding pad
Specification Data:
81349-mil-c-55681/8 government specification
Shelf Life:
N/a
Unit Of Measure:
Demilitarization:
No
Fiig:

A010b0